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FDD10N20LZ N-Channel UniFET[™] MOSFET **200 V, 7.6 A, 360 m**Ω

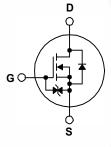
Features

- R_{DS(on)} = 300 mΩ (Typ.) @ V_{GS} = 10 V, I_D = 3.8 A
- Low Gate Charge (Typ. 12 nC)
- Low C_{rss} (Typ. 11 pF)
- 100% Avalanche Tested
- Improved dv/dt Capability
- · ESD Improved Capability
- RoHS Compliant

Applications

- Lighting
- Uninterruptible Power Supply
- AC-DC Power Supply





This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche en-

ergy strength. This device family is suitable for switching power

converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp bal-

Description

lasts.

MOSFET Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter			FDD10N20LZTM	Unit	
V _{DSS}	Drain to Source Voltage			200	V	
V _{GSS}	Gate to Source Voltage			±20	V	
	Drain Current	- Continuous (T _C = 25 ^o C)		7.6		
I _D	Drain Current	- Continuous (T _C = 100 ^o C)		4.5	- A	
I _{DM}	Drain Current	- Pulsed (Note 1)		30	А	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)			121	mJ	
I _{AR}	Avalanche Current (Not			7.6	А	
E _{AR}	Repetitive Avalanche Energy		(Note 1)	8.3	mJ	
dv/dt	Peak Diode Recovery dv/dt (Note 3)		(Note 3)	4.5	V/ns	
P _D	Devuer Dissinction	$(T_{\rm C} = 25^{\rm o}{\rm C})$		83	W	
	Power Dissipation	- Derate Above 25°C		0.7	W/ºC	
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C	
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		Seconds	300	°C	

Thermal Characteristics

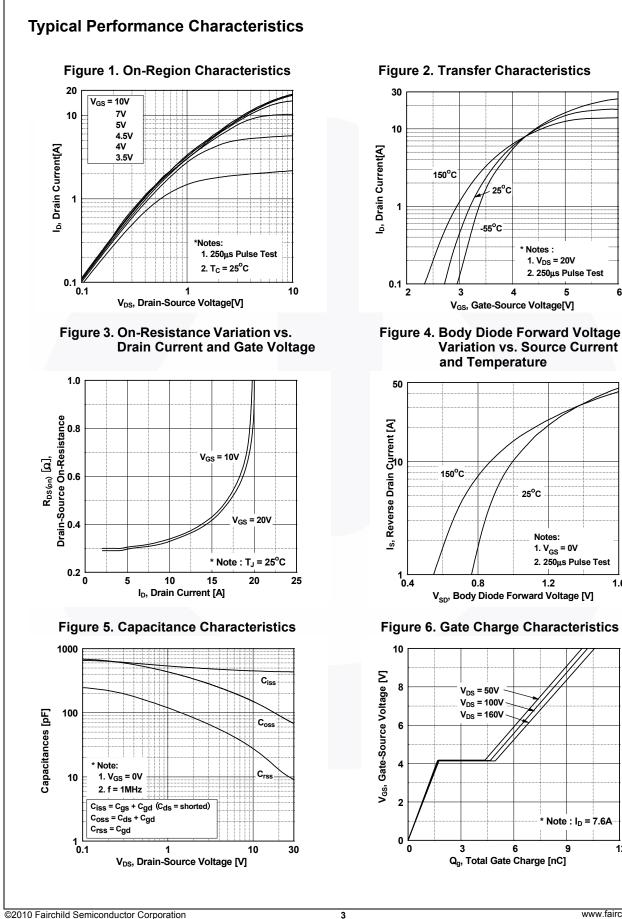
Symbol	Parameter	FDD10N20LZTM	Unit
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction to Case, Max.	1.5	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient, Max.	110	0/00

Part NumberTop MarkFFDD10N20LZTMFDD10N20LZ		Packag	ackage Packing Method Reel Size		e Ta	ape Width	Qu	Quantity		
		DPAK	Тар	e and Reel	330 mm		16 mm	250	2500 units	
Electrical	Chara	cteristics T _C = 25°	'C unless ot	therwise nc	oted.					
Symbol		Parameter		Test Conditions			Min.	Тур.	Max.	Unit
Off Charac	teristics									
BV _{DSS}	-	Source Breakdown Voltag	ne I	lo = 250 µA	$V_{cc} = 0 V T$	° = 25°C	200	-		V
ΔΒV _{DSS} / ΔΤ _J	Breakdown Voltage Temperature Coefficient			$I_D = 250 \ \mu\text{A}, \ V_{GS} = 0 \ V, \ T_C = 25^{\circ}\text{C}$ $I_D = 250 \ \mu\text{A}, \ \text{Referenced to } 25^{\circ}\text{C}$		-	0.2	-	V/°C	
7 Δ1 J	COEIIICIEI	11)	Vpc = 200 '	V, V _{GS} = 0 V		-	-	1	
I _{DSS}	Zero Gate	e Voltage Drain Current			V, T _C = 125 ^o C		-	-	10	μA μA
I _{GSS}	Gate to B	Body Leakage Current			$V, V_{DS} = 0 V$		-	-	±10	
On Charact										<u> </u>
		ashald Valtage			1 - 250 4		2.0		2.0	V
V _{GS(th)}	Gate Thre	eshold Voltage			$I_{\rm D} = 250 \mu \text{A}$		2.0		3.0	V
R _{DS(on)}	Static Drain to Source On Resistance				$I_{\rm D} = 3.8 {\rm A}$		-	0.30	0.36	Ω
	Forward	Forward Transconductance		$V_{GS} = 5 V, I_D = 3.8 A$ $V_{DS} = 20 V, I_D = 3.8 A$			-	0.32	0.38	S
9 _{FS}	TOIWalu	Transconductance		v _{DS} - 20 v	, i <u>D</u> = 3.0 A			0		5
Dynamic C	haracter	istics								
C _{iss}	Input Cap	pacitance		V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz		-	440	585	pF	
C _{oss}	Output Ca	apacitance				-	75	100	pF	
C _{rss}	Reverse	Transfer Capacitance				-	11	17	pF	
Q _{g(tot)}	Total Gate	e Charge at 10V	١	V _{DS} = 100	V, I _D = 7.6 A,		-	12	16	nC
Q _{gs}	Gate to S	ource Gate Charge	١	V _{GS} = 10 V (Note 4)		-	2	-	nC	
Q _{gd}	Gate to D	orain "Miller" Charge				-	3.5	-	nC	
Switching	Charact∉	eristics								
t _{d(on)}	Turn-On Delay Time					-	10	30	ns	
t _r	Turn-On F	Rise Time			V, I _D = 7.6 A,	-	-	15	40	ns
t _{d(off)}	Turn-Off [Delay Time	'	V _{GS} = 10 V	, R _G = 25 Ω		-	55	120	ns
t _f	Turn-Off F	all Time				(Note 4)	-	25	60	ns
Drain-Sour	ce Diode	e Characteristics								
I _S	Maximum Continuous Drain to Source Diode Forward Current						-	-	7.6	A
I _{SM}	Maximum	Pulsed Drain to Source	Diode Forw	Forward Current			-	-	30	Α
V _{SD}		Source Diode Forward Vo	1	V _{GS} = 0 V, I _{SD} = 7.6 A		-	-	1.4	V	
t _{rr}	Reverse F	Recovery Time		$V_{GS} = 0 V, I_{SD} = 7.6 A,$			-	115	-	ns
Q _{rr}	Reverse F	Recovery Charge			/dt = 100 A/μs		-	0.5	-	μC
2. L = 4.2 mH, I_{AS} = 3. $I_{SD} \le 7.6$ A, di/dt	= 7.6 A, V _{DD} = ≤ 200 A/μs, V _D	mited by maximum junction tempe 50 V, $R_G = 25 \Omega$, starting $T_J = 25^{\circ}$ $_{2D} \le BV_{DSS}$, starting $T_J = 25^{\circ}$ C. rating temperature typical charact	°C.							

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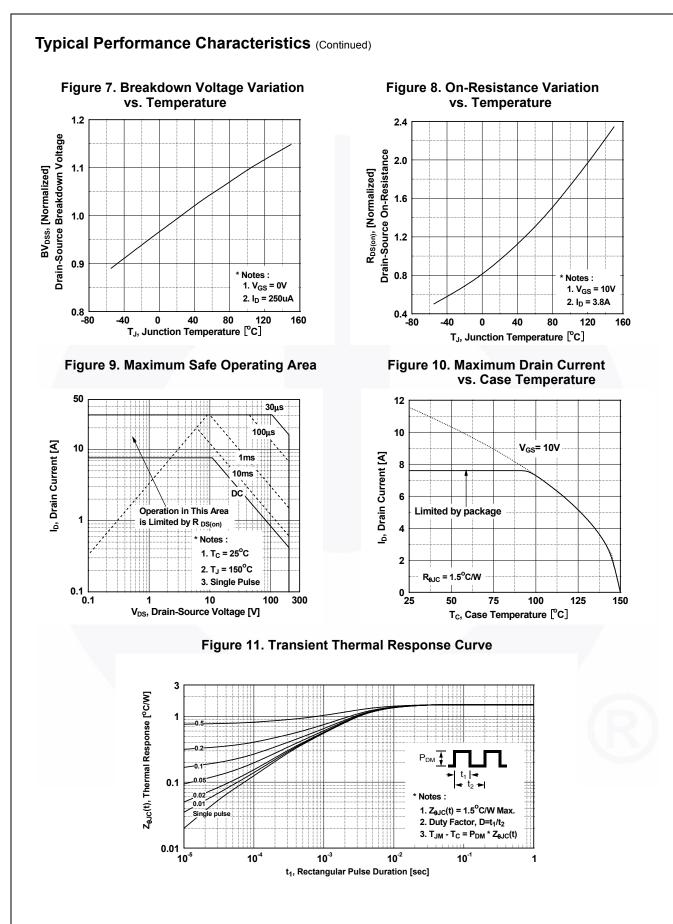
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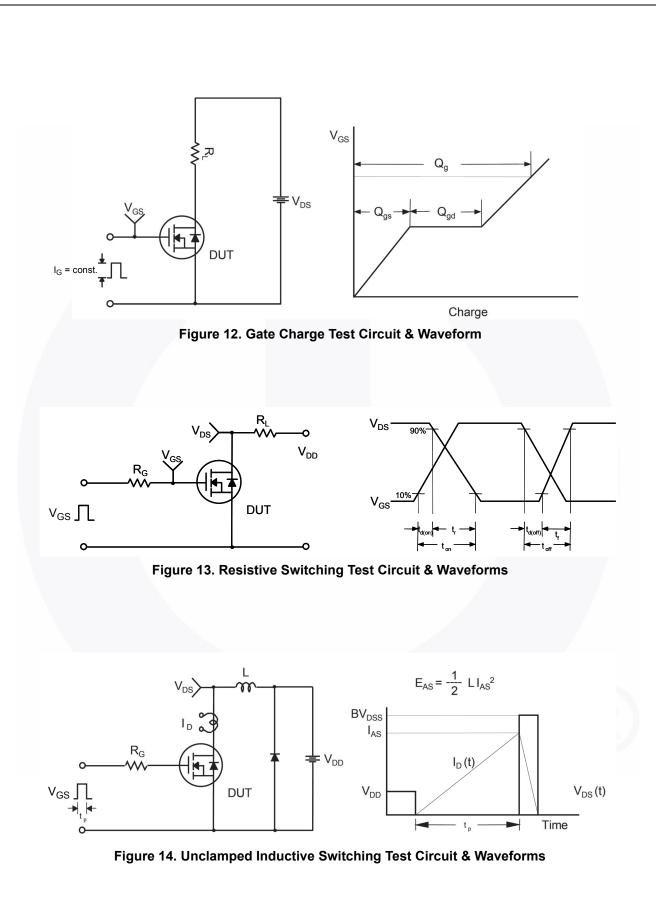


FDD10N20LZ Rev. C1

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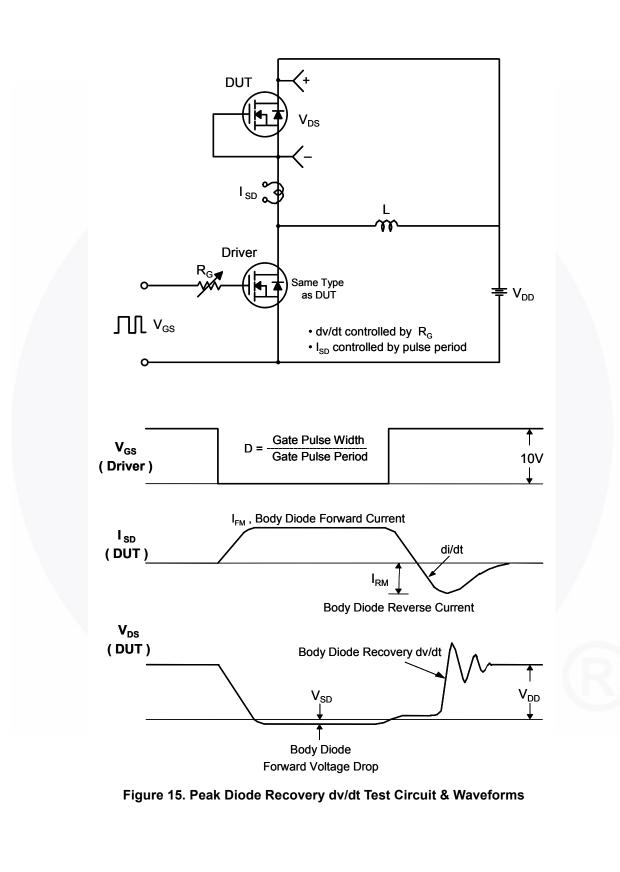
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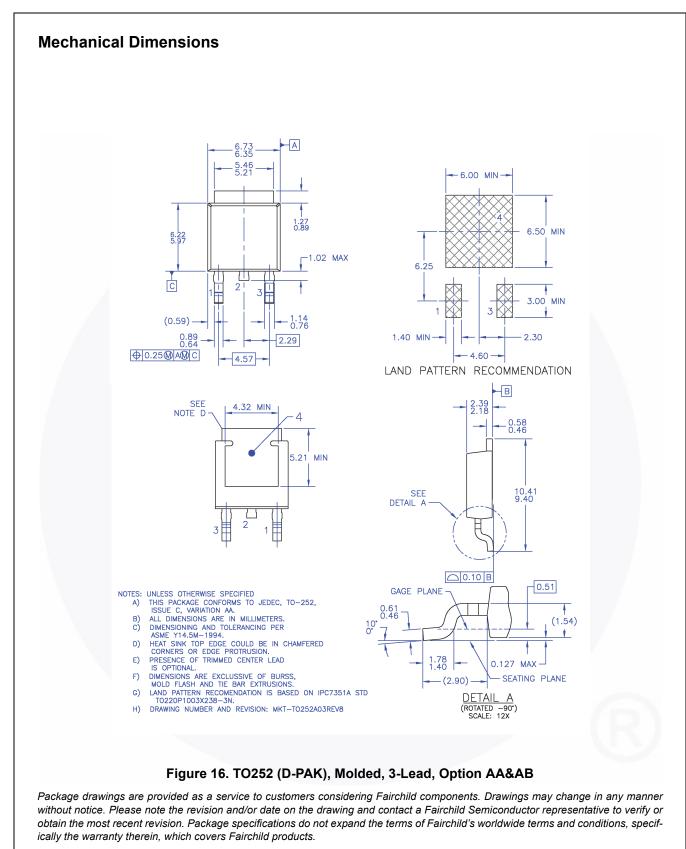




FDD10N20LZ — N-Channel UniFETTM MOSFET

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